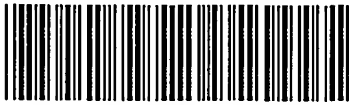


# Search Notes



Application/Control No.

10/773,158

Examiner

Hae M. Hyeon

Applicant(s)/Patent under Reexamination

TANIGUCHI ET AL.

Art Unit

2839

## SEARCHED

Class	Subclass	Date	Examiner
439	760	4/05	hnh
439	95	↓	↓
439	97		
439	98		
439	801	↓	↓

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Plus Search Done	4/05	hnh